

<b>Notice of References Cited</b>	Application/Control No. 10/629,743		Applicant(s)/Patent Under Reexamination WAKUTA ET AL.	
	Examiner John D. Walters		Art Unit 3618	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,842,534	12-1998	Frank, Andrew A.	180/65.2
*	B	US-5,895,333	04-1999	Morisawa et al.	475/5
*	C	US-6,146,302	11-2000	Kashiwase, Hajime	475/5
*	D	US-6,203,468	03-2001	Nitta et al.	477/5
*	E	US-6,554,736	04-2003	Takano et al.	477/5
*	F	US-6,558,287	05-2003	Hayabuchi et al.	475/271
*	G	US-6,600,980	07-2003	Kraska et al.	701/22
*	H	US-2003/0218447	11-2003	Coates et al.	320/134
*	I	US-6,740,002	05-2004	Stridsberg, Lennart	477/14
*	J	US-2004/0103719	06-2004	Raftari et al.	073/118.1
*	K	US-6,752,738	06-2004	Martin et al.	475/276
*	L	US-2004/0254045	12-2004	McGee et al.	477/003
*	M	US-6,907,325	06-2005	Syed et al.	701/22

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.